

Notice of References Cited		Application/Control No. 10/810,445	Applicant(s)/Patent Under Reexamination LEHE ET AL.	
		Examiner Victor X. Nguyen	Art Unit 3734	Page 1 of 1

U.S. PATENT DOCUMENTS

*	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A US-5,059,183	10-1991	Semrad, Neal	604/158
*	B US-6,152,946	11-2000	Broome et al.	606/200
*	C US-5,662,703	09-1997	Yurek et al.	623/1.12
D	US-			
E	US-			
F	US-			
G	US-			
H	US-			
I	US-			
J	US-			
K	US-			
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FOREIGN PATENT DOCUMENTS

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N					
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NON-PATENT DOCUMENTS

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